

STP62NS04Z

N-channel clamped 12.5m Ω - 62A - TO-220 Fully protected MESH OVERLAYTM Power MOSFET

General features

Туре	V _{DSS} (@Tjmax)	R _{DS(on)}	I _D
STP62NS04Z	Clamped	<0.015Ω	62A

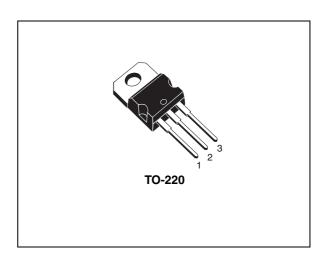
- 100% avalanche tested
- Low capacitance and gate charge
- 175° C maximum junction temperature

Description

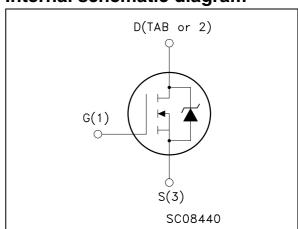
This fully clamped MOSFET is produced by using the latest advanced Company's Mesh Overlay process which is based on a novel strip layout. The inherent benefits of the new technology coupled with the extra clamping capabilities make this product particularly suitable for the harshest operation conditions such as those encountered in the automotive environment. Any other application requiring extra ruggedness is also recommended.

Applications

Switching application



Internal schematic diagram



Order codes

Part number	Marking	Package	Packaging
STP62NS04Z	P62NS04Z	TO-220	Tube

www.Data Contents STP62NS04Z

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www.Data STP62NS04Z Electrical ratings

1 Electrical ratings

Table 1. Absolute maximum ratings

Symbol	Parameter	Value	Unit
V _{DS}	Drain-source voltage (V _{GS} = 0)	Clamped	V
V _{GS}	Gate-source voltage	Clamped	V
I _D	Drain current (continuous) at T _C = 25°C	62	Α
I _D	Drain current (continuous) at T _C =100°C	37.5	Α
I _{DG}	Drain gate current (continuous)	± 50	
I _{GS}	Gate sourcecurrent (continuous)	± 50	
I _{DM} ⁽¹⁾	Drain current (pulsed)	248	Α
P _{TOT}	Total dissipation at T _C = 25°C	110	W
	Derating factor	0.74	W/°C
dv/dt (2)	Peak diode recovery voltage slope	8	V/ns
E _{AS} (3)	Single Pulse Avalanche Energy	500	mJ
V _{ESD}	ESD (HBM - C = 100pF, R = 1.5 kΩ)	8	V
T _J T _{stg}	Operating junction temperature Storage temperature	-55 to 175	°C

^{1.} Pulse width limited by safe operating area

Table 2. Thermal data

Symbol	Parameter	Value	Unit
R _{thJC}	Thermal resistance junction-case Max	1.36	°C/W
R _{thJA}	Thermal resistance junction-ambient Max	62.5	°C/W
T _I	Maximum lead temperature for soldering purpose	300	°C

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^{2.} $I_{SD} \leq 40A$, di/dt $\leq 100A/\mu s$, $V_{DD} \leq V_{(BR)DSS}$, $T_j \leq T_{JMAX}$

^{3.} Starting $T_J = 25$ °C, $I_D = 20A$, $V_{DD} = 20V$

2 Electrical characteristics

(T_{CASE}=25°C unless otherwise specified)

Table 3. On/off states

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
V _{(BR)DSS}	Drain-source breakdown voltage	$I_D = 1$ mA, $V_{GS} = 0$	33			V
I _{DSS}	Zero gate voltage drain current (V _{GS} = 0)	V _{DS} = 16V			10	μΑ
I _{GSS}	Gate body leakage current (V _{DS} = 0)	V _{GS} = ±10V			10	μА
V _{GSS}	Gate-Source Breakdown Voltage	I _{GS} = 100 μA	18			V
V _{GS(th)}	Gate threshold voltage	$V_{DS} = V_{GS}, I_{D} = 250 \mu A$	2		4	V
R _{DS(on)}	Static drain-source on resistance	$V_{GS} = 10V, I_D = 30A$		12.5	15	mΩ

Table 4. Dynamic

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
g _{fs} ⁽¹⁾	Forward transconductance	$V_{DS} = 15V, I_D = 30A$		20		S
C _{iss} C _{oss} C _{rss}	Input capacitance Output capacitance Reverse transfer capacitance	V _{DS} =25V, f = 1 MHz, V _{GS} = 0		1330 420 135		pF pF pF
Q _g Q _{gs} Q _{gd}	Total gate charge Gate-source charge Gate-drain charge	$V_{DD} = 20V, I_{D} = 40A$ $V_{GS} = 10V$		34 10 11.5	47	nC nC nC

^{1.} Pulsed: pulse duration=300µs, duty cycle 1.5%

Table 5. Switching times

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
t _{d(on)} t _r t _{d(off)} t _f	Turn-on delay time Rise time Turn-off delay time Fall time	V_{DD} = 20V, I_{D} = 20A, R_{G} =4.7 Ω , V_{GS} = 10V Figure 13 on page 8		13 104 41 42		ns ns ns ns
t _{r(Voff)} t _f t _c	Off-voltage rise time Fall time Cross-over time	$V_{clamp} = 30V, I_D = 40A$ $R_G = 4.7\Omega, V_{GS} = 10V$ Figure 13 on page 8		30 54 90		ns ns ns

Table 6. Source drain diode

Symbol	Parameter	Test conditions	Min	Тур.	Max	Unit
I _{SD}	Source-drain current				62	Α
I _{SDM} ⁽¹⁾	Source-drain current (pulsed)				248	Α
V _{SD} ⁽²⁾	Forward on voltage	$I_{SD} = 62A, V_{GS} = 0$			1.5	V
t _{rr} Q _{rr} I _{RRM}	Reverse recovery time Reverse recovery charge Reverse recovery current	I_{SD} = 40A, di/dt = 100A/µs, V_{DD} = 20V, T_{J} = 150°C Figure 15 on page 8		45 65 2.9		ns μC A

^{1.} Pulse width limited by safe operating area

^{2.} Pulsed: pulse duration=300µs, duty cycle 1.5%

Electrical characteristics (curves) 2.1

Figure 1. Safe operating area

Figure 2. Thermal impedance

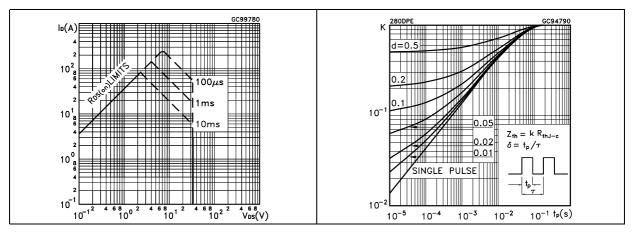


Figure 3. **Output characterisics**

Figure 4. **Transfer characteristics**

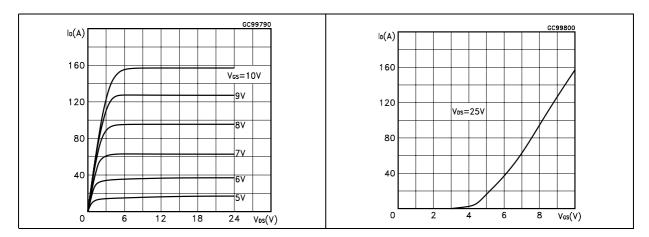
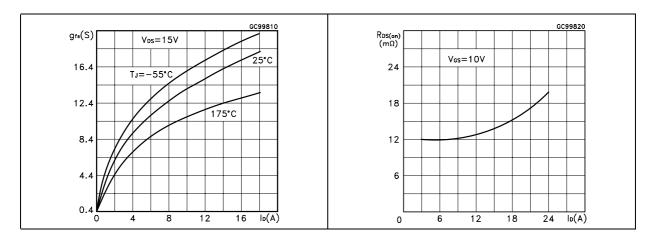


Figure 5. **Transconductance**

Static drain-source on resistance



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www.Data STP62NS04Z Electrical characteristics

Figure 7. Gate charge vs gate-source voltage Figure 8. Capacitance variations

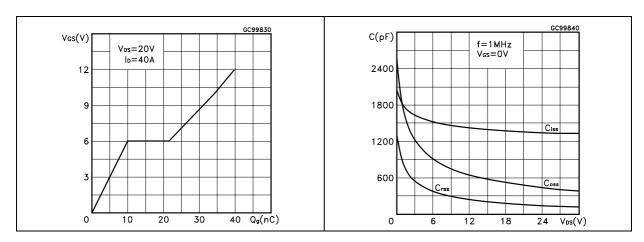


Figure 9. Normalized gate threshold voltage vs temperature

Figure 10. Normalized on resistance vs temperature

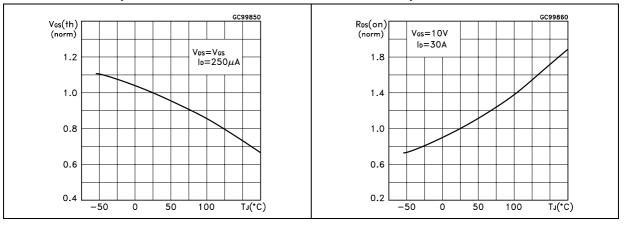
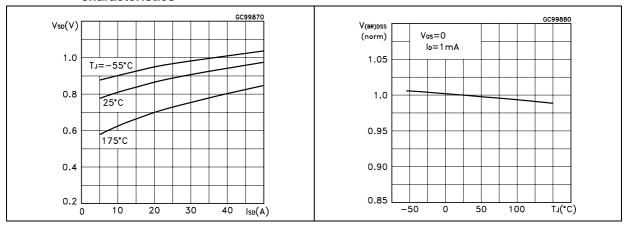


Figure 11. Source-drain diode forward characteristics

Figure 12. Normalized B_{VDSS} vs temperature



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3 Test circuit

Figure 13. Switching times test circuit for resistive load

Figure 14. Gate charge test circuit

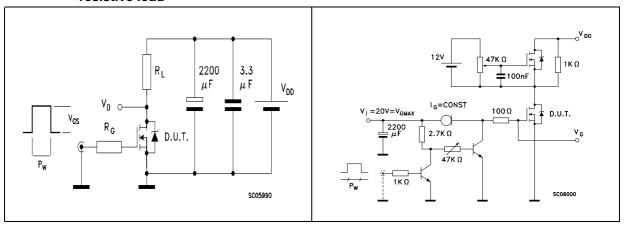


Figure 15. Test circuit for inductive load switching and diode recovery times

Figure 16. Unclamped Inductive load test circuit

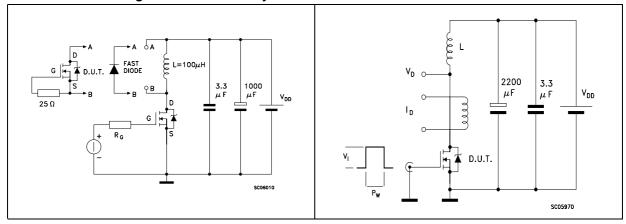
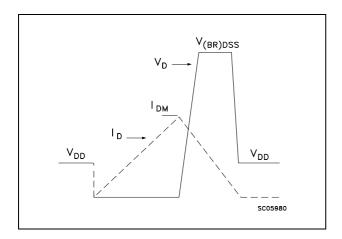


Figure 17. Unclamped inductive waveform



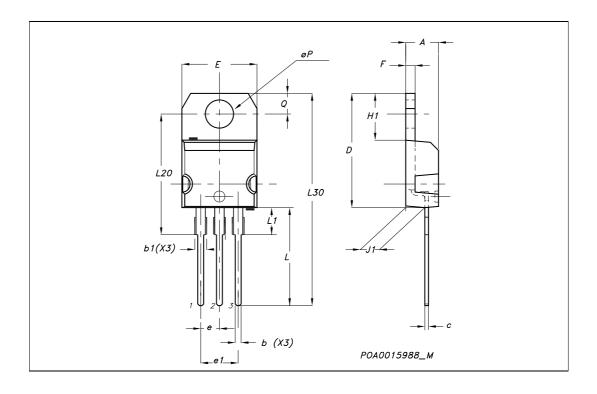
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4 Package mechanical data

In order to meet environmental requirements, ST offers these devices in ECOPACK® packages. These packages have a Lead-free second level interconnect . The category of second level interconnect is marked on the package and on the inner box label, in compliance with JEDEC Standard JESD97. The maximum ratings related to soldering conditions are also marked on the inner box label. ECOPACK is an ST trademark. ECOPACK specifications are available at: www.st.com

TO-220 MECHANICAL DATA

DIM.		mm.			inch	
DIW.	MIN.	TYP	MAX.	MIN.	TYP.	MAX.
Α	4.40		4.60	0.173		0.181
b	0.61		0.88	0.024		0.034
b1	1.15		1.70	0.045		0.066
С	0.49		0.70	0.019		0.027
D	15.25		15.75	0.60		0.620
Е	10		10.40	0.393		0.409
е	2.40		2.70	0.094		0.106
e1	4.95		5.15	0.194		0.202
F	1.23		1.32	0.048		0.052
H1	6.20		6.60	0.244		0.256
J1	2.40		2.72	0.094		0.107
L	13		14	0.511		0.551
L1	3.50		3.93	0.137		0.154
L20		16.40			0.645	
L30		28.90			1.137	
øΡ	3.75		3.85	0.147		0.151
Q	2.65		2.95	0.104		0.116



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www.Data STP62NS04Z Revision history

5 Revision history

Table 7. Revision history

Date	Revision	Changes
21-Jun-2004	2	Preliminary datasheet
22-Aug-2005	3	Complete document with curves
21-Jan-2006	4	New ECOPAK label
02-Oct-2006	5	New template, no content change

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